Unit: mm

TOSHIBA Transistor Silicon NPN Epitaxial Planar Type

2SC5765

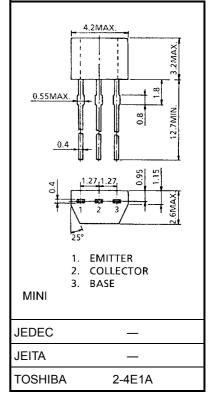
MEDIUM POWER AMPLIFIER APPLICATIONS STOROBO FLASH APPLICATIONS

• Low Saturation Voltage: V_{CE} (sat) (1) = 0.27 V (max.) (I_C = 3 A/I_B = 60 mA)

Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit	
Collector-Base voltage		V _{CBO}	15	V	
Collector-Emitter voltage		V _{CEO}	10	V	
Emitter-Base voltage		V _{EBO}	7	V	
Collector current	DC	Ι _C	5	А	
	Pulsed	I _{CP}	9		
Collector power dissipation		P _C (Note1)	550	mW	
Junction temperature		Tj	150	°C	
Storage temperature range		T _{stg}	–55 to 150	°C	

Note 1: When a device is mounted on a glass epoxy board (35 mm \times 30 mm \times 1mm)



Weight: 0.13 g

Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Collector cut-off current	I _{CBO}	$V_{CB} = 15 \text{ V}, \text{ I}_{E} = 0$			0.1	μA
Emitter cut-off current	I _{EBO}	$V_{EB} = 5 V, I_{C} = 0$	_	_	0.1	μA
Collector-Emitter breakdown voltage	V _{(BR)CEO}	$I_C = 1 \text{ mA}, I_B = 0$	10	_	_	V
DC current gain	h _{FE(1)} (Note2)	$V_{CE} = 1.5 \text{ V}, I_{C} = 0.5 \text{ A}$	450		700	
	h _{FE(2)} (Note2)	$V_{CE} = 1.5 \text{ V}, I_{C} = 2 \text{ A}$	320	_		
	h _{FE(3)} (Note2)	$V_{CE} = 1.5 \text{ V}, I_{C} = 5 \text{ A}$	170	_	_	
Collector-Emitter saturation voltage	V _{CE (sat)} (Note2)	$I_{C} = 3 \text{ A}, I_{B} = 60 \text{ mA}$	_	_	0.27	V
Collector-Output Capacitance	C _{ob}	$V_{CB} = 10 \text{ V}, \text{ I}_{E} = 0, \text{ f} = 1 \text{ MHz}$	_	25	_	pF

Note 2: Pulse test

TOSHIBA

DC Operation

*:Single Nonrepetitive Pulse

Curves must be derated linearly with increase in temperature.

0.1

1

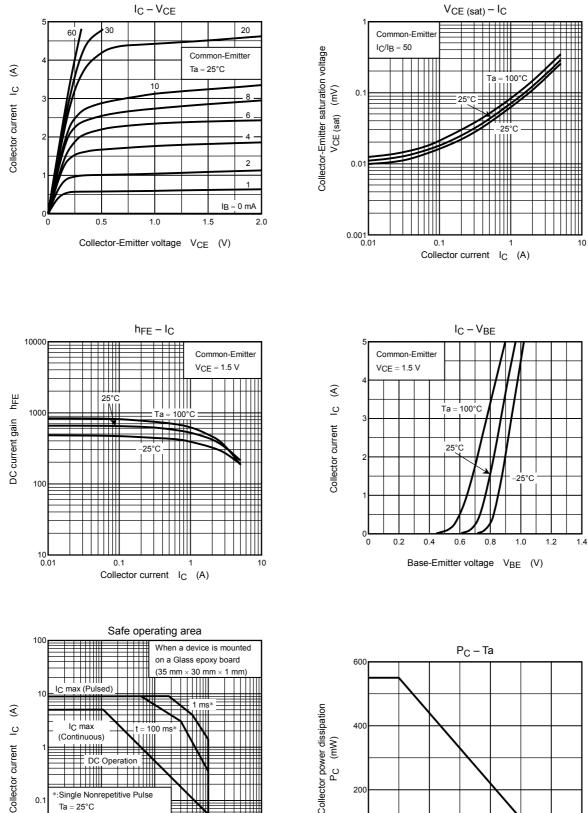
Collector-Emitter voltage V_{CE} (V)

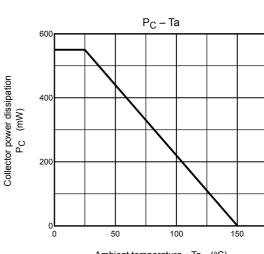
Ta = 25°C

0.1

0.01 0.01

10





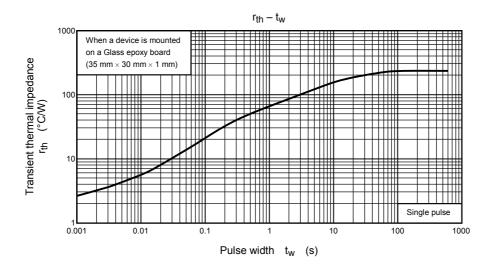
Ambient temperature Ta (°C)

2002-01-16

VCEO max

100

10



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